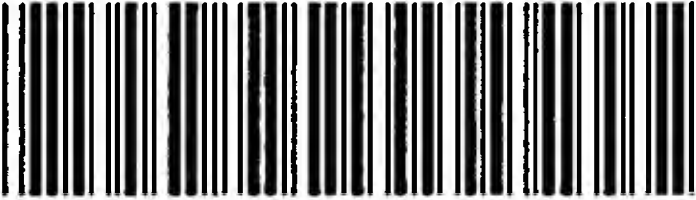


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/708,818	WOZNIAK ET AL.	
	Examiner	Art Unit	
	Tien Dinh	3644	

SEARCHED			
Class	Subclass	Date	Examiner
244	135C 135R	4/27/05	DB

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Inter			
to		4/27/05	TD
above			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR